

<b>Search Notes</b> 	<b>Application/Control No.</b>  <b>10/694,197</b>	<b>Applicant(s)/Patent under Reexamination</b>  <b>HWANG ET AL.</b>
	<b>Examiner</b>  <b>KHAI TRAN</b>	<b>Art Unit</b>  <b>2611</b>

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
375	265, 267 340, 343	9/14/07	LLT
375	302, 299		
455	272		
714	746, 754		